

Thin Film Ceramic Strain Sensor Development for High Temperature Environments

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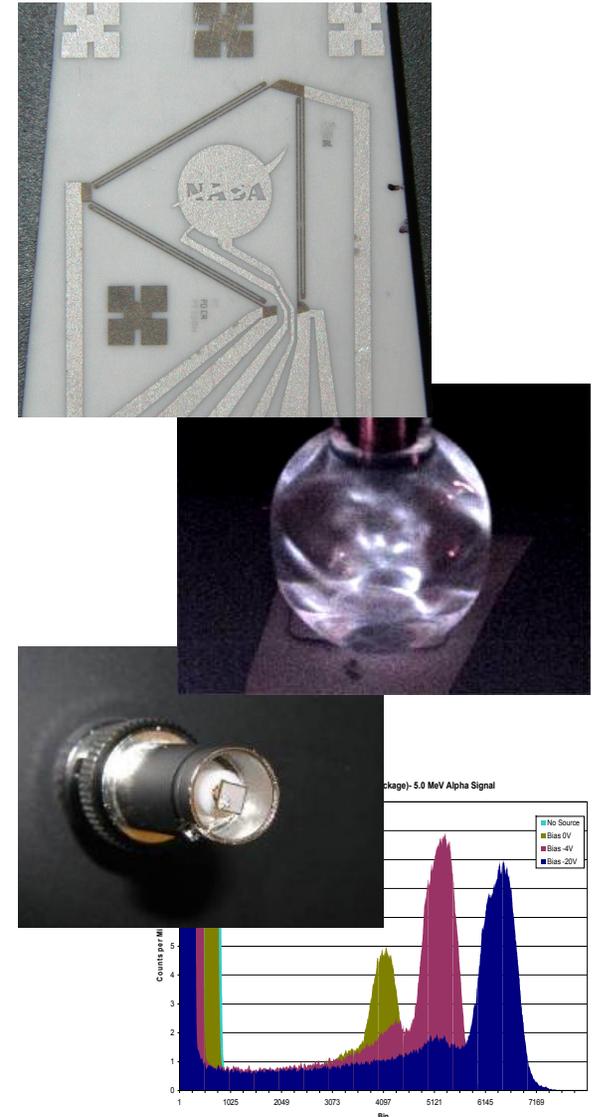
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The Researchers

John Wrbanek & Gus Fralick

- Research Engineers / Physicists at NASA Glenn Research Center Sensors & Electronics Branch (GRC/RIS)
- Primarily Physical Sensors Instrumentation Research:
 - Thin Film Sensors
 - Temperature
 - Strain
 - Flow
- Also conduct research in Radiation Detectors, Sonoluminescence & other Revolutionary Concepts

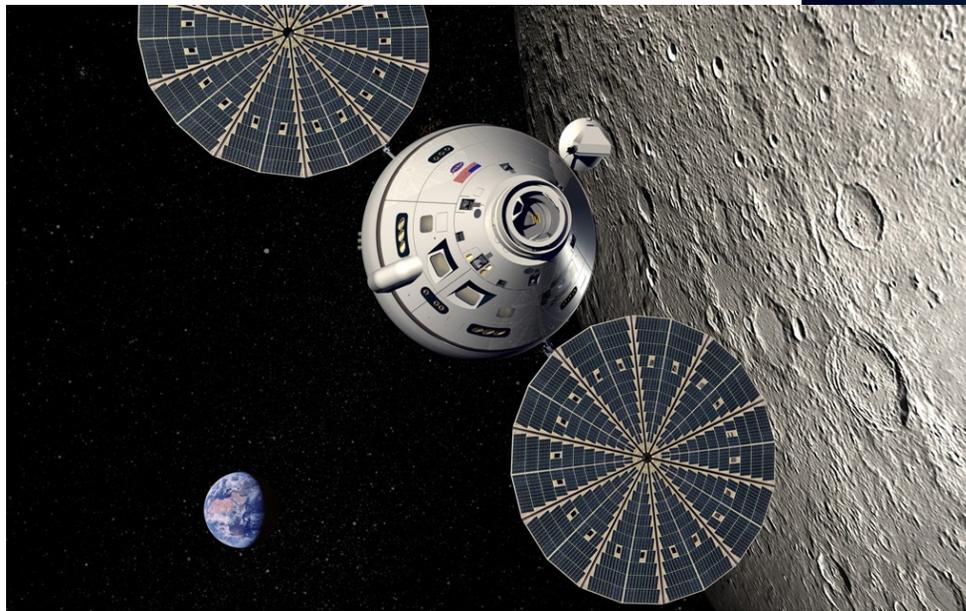




NASA's Mission: To pioneer the future in space exploration, scientific discovery, and aeronautics research

“Advance knowledge in the fundamental disciplines of aeronautics, and develop technologies for safer aircraft and higher capacity airspace systems.”

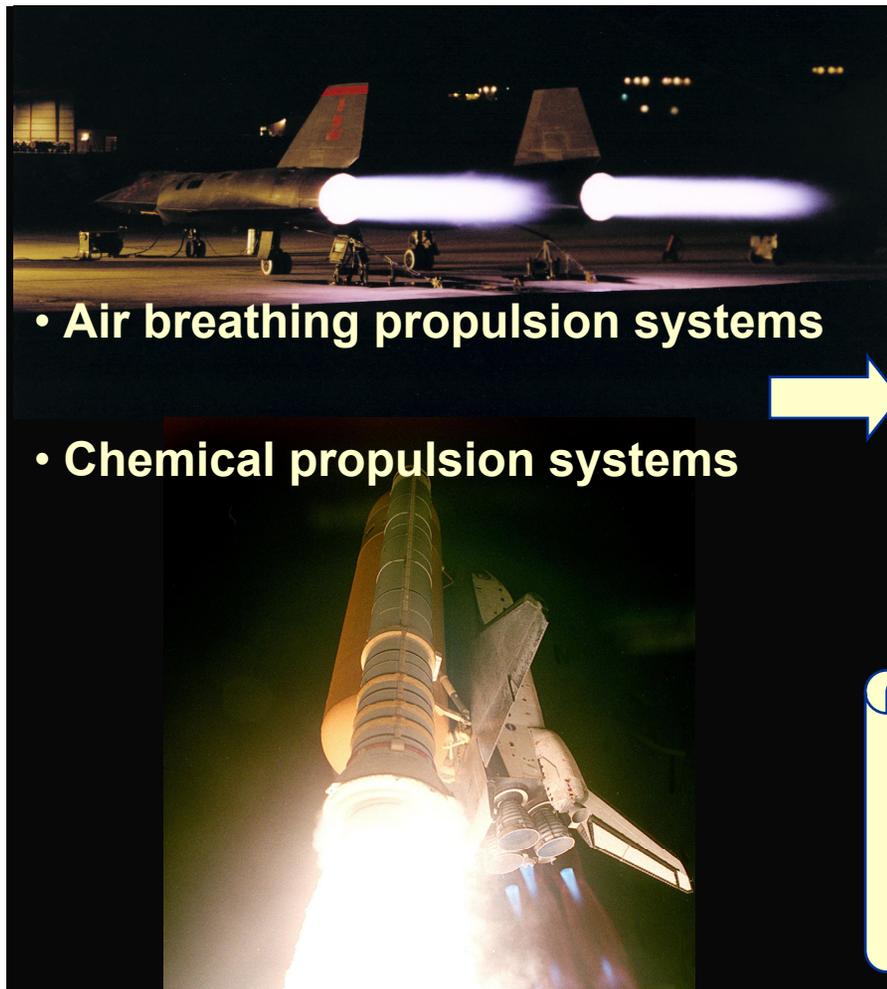
– NASA 2006 Strategic Plan



“Develop the innovative technologies, knowledge, and infrastructures both to explore and support decisions about the destinations for human exploration”
– Vision for Space Exploration



Instrumentation Challenges for Propulsion System Environments



- Air breathing propulsion systems
- Chemical propulsion systems

- High gas temperatures
- High material temperatures ($>1000^{\circ}\text{C}$)
- Rapid thermal transients
- High gas flows
- High combustion chamber pressures

Wire-based sensors are bulky and disruptive to the true operating environment



Physical Issues for Life Prediction of Engine Hot Section

- Centrifugal Stress
- Thermal Stress
- Vibrational Stress from gas flow
- Contact Stresses from different materials (Thermal Expansions, Deformations)
- Blade Clearance (Creep)

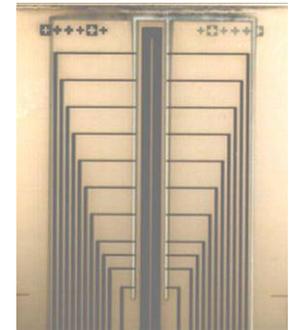




Thin Film Physical Sensors for High Temperature Applications

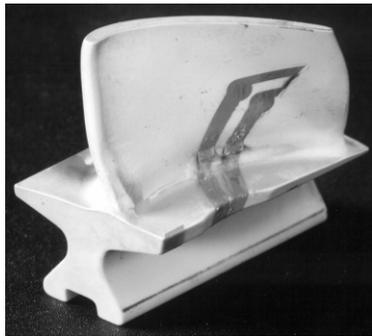
Advantages for temperature, strain, heat flux, flow & pressure measurement:

- ◆ Negligible mass & minimally intrusive (microns thick)
- ◆ Applicable to a variety of materials including ceramics
- ◆ Minimal structural disturbance (minimal machining)
- ◆ Intimate sensor to substrate contact & accurate placement
- ◆ High durability compared to exposed wire sensors
- ◆ Capable for operation to very high temperatures (>1000°C)



Multifunctional smart sensors being developed

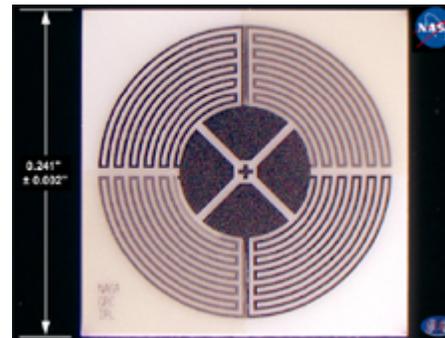
Flow sensor made of high temperature materials



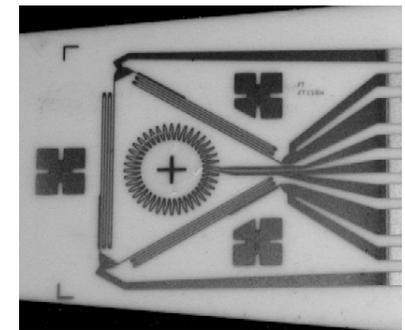
PdCr strain sensor to T=1000°C



Pt- Pt/Rh temperature sensor to T=1200°C



Heat Flux Sensor Array to T=1000°C



Multifunctional Sensor Array



Physical Sensors Facilities



Sputtering PVD Systems

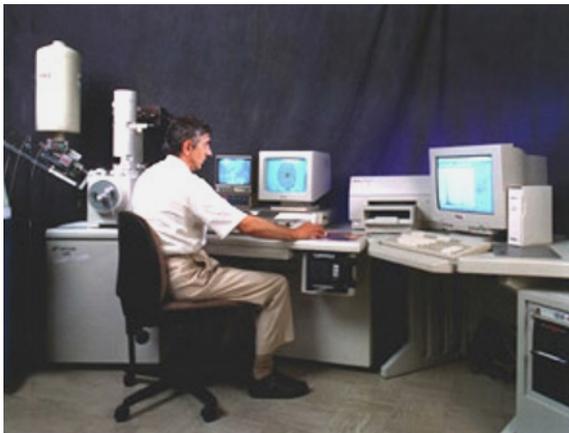
Sensing Film layers are fabricated with physical vapor deposition methods (sputter deposition, e-beam vapor deposition)

Sensors are patterned by photolithography methods and/or stenciled masks



Microfabrication Clean Room

Evaluation of thin films with in-house Materials Characterization Facilities

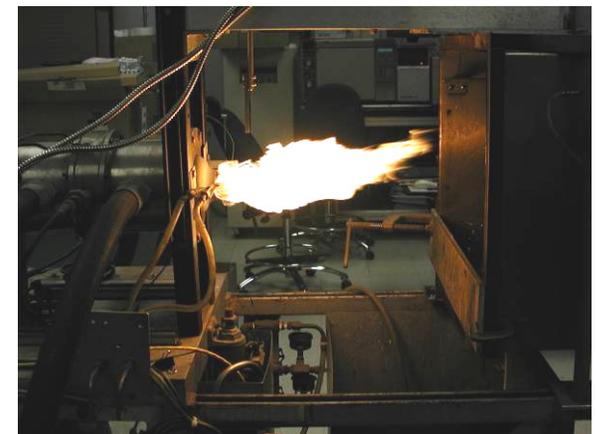


SEM/EDAX

Testing of films with in-house high-temperature furnaces & burn rigs



Thin Film Characterization Lab

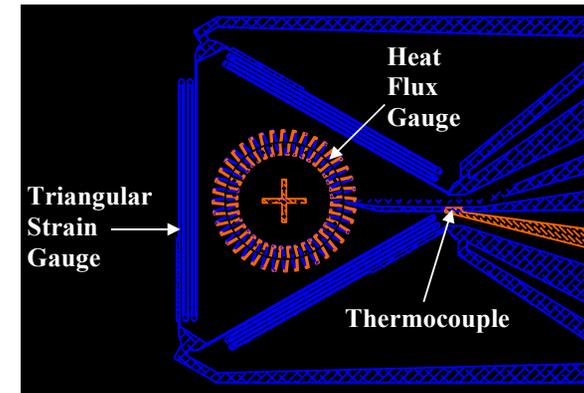


ERB Burn Rig

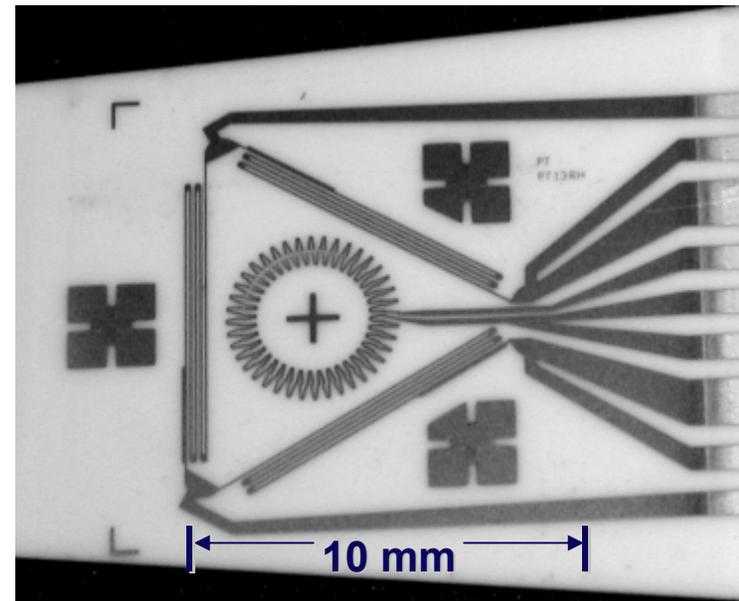


Multi-Functional Sensor System

- Multifunctional thin film sensor designed and built in-house (US Patent 5,979,243)
- Temperature, strain, and heat flux with flow all in the same microsensor
- Fine-line patterned sensing elements of Palladium-Chromium alloy (PdCr), Platinum-Rhodium alloy (PtRh) and Platinum (Pt)
- Enables measurements on component surfaces, and reduces boundary layer trip on metals compared to wires or foils
- Weldable shim designed to simplify sensor mounting
- Dynamic measurements demonstrated in lab



Schematic of Multifunctional Sensor



Multifunctional Sensor Prototype

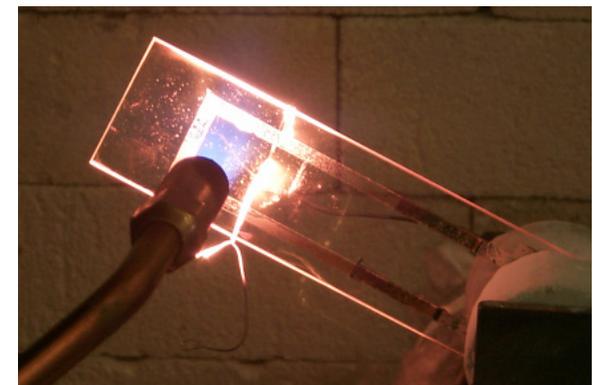


Application of Ceramics as Thin Film Sensors

- The limits of noble metal thin film sensors of 1100°C (2000°F) may not be adequate for the increasingly harsh conditions of advanced aircraft and launch technology ($>1650^{\circ}\text{C}/3000^{\circ}\text{F}$)
- NASA GRC investigating ceramics as thin film sensors for extremely high temperature applications
- Advantages of the stability and robustness of ceramics and the non-intrusiveness of thin films
- Advances have been made in ceramic thin film sensors through collaborations with Case Western Reserve University (CWRU) and University of Rhode Island (URI)



**Ceramic TC Sputtering Targets
fabricated by the CWRU &
NASA GRC Ceramics Branch**

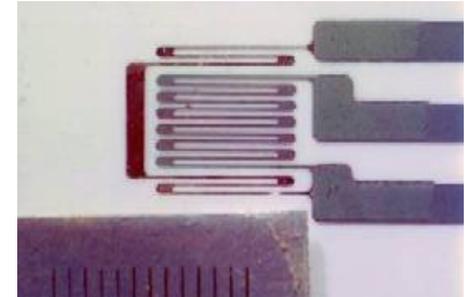


Ceramic TC fabricated at URI

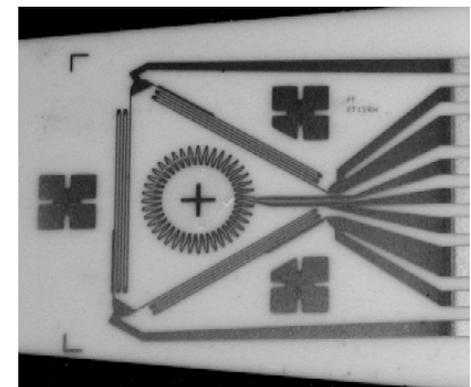


Considerations for Static Strain Gauges

- Required accuracy: $\pm 200 \mu\epsilon$ ($\pm 10\%$ full scale)
 - Currently accomplished with a temperature compensating bridge circuit with PdCr in a limited temperature range
- Multifunctional Sensor design does not lend itself to compensating bridges
 - Multiple strain gauges in a rosette pattern does not allow compensation to be included in design
 - Design eliminates temperature effects if apparent strain is low enough
- High Temperature Static Strain measurements with Multifunctional Sensor requires a more passive method of reducing or eliminating apparent strain
- Temperature Sensitivity Goal: $< \pm 20 \mu\epsilon / ^\circ\text{C}$



PdCr Strain Gauge in Compensation Bridge



Multifunctional Sensor Design



Apparent Strain

- Gauge factor (γ) of the strain gauge relates the sensitivity of the gauge to Strain (ϵ):

$$\frac{\delta R}{R} = \gamma \frac{\delta l}{l} = \gamma \epsilon$$

- Apparent Strain (ϵ_a) can be falsely interpreted as actual strain due to the gauge's Temperature Coefficient of Resistance (TCR) and Coefficient of Thermal Expansion (CTE):

$$\epsilon_a = \left(\frac{TCR}{\gamma} + \Delta CTE \right) \Delta T$$

- Goal: To minimize apparent strain by minimizing TCR and maximizing gauge factor



Past Ceramic-Based Sensor Development

Gauge Material	TCR (ppm/°C)	Gauge Factor (γ) ($\delta R/R/\epsilon$)	Apparent Strain Sensitivity ($\epsilon_a/\Delta T$)($\mu\epsilon/^\circ\text{C}$)	Maximum Use Temperature
Ni-20%Cr (ONERA,1993)	+290	2.5	+116	700°C
Pd-13%Cr (GRC, 1998)	+135	2 –1.4	+85	1100°C
AlN (URI, 1996)	-1281 – +109	3.72–15	-344 - +29	>1100°C
ITO (URI, 1996)	-469 – +230	-6.5– -11.4	-35 - +72	>1100°C
Al:ITO (URI, 2005)	-1200	8	-150	1280°C
TaN (CEIT, 1994)	-80	3.5	-23	<3000°C
TaON (CEIT, 1995)	-290	3.5	-83	<3000°C
Cu:TaN (NTU, 2004)	-800 – +200	2.3–5.1	-348 - +87	<3000°C
TiB ₂ (HTW, 2006)	-50	1.4	-36	<3000°C



Tantalum Nitride Sensor Fabrication

Tantalum Nitride (TaN) Test Films

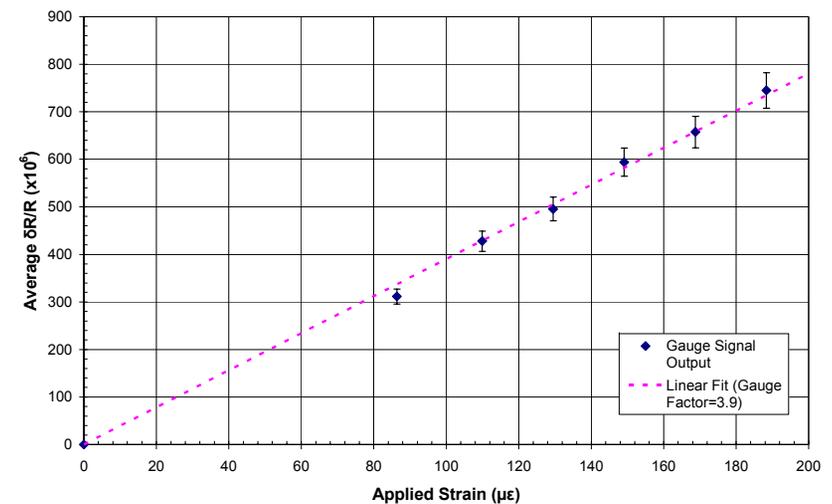
- Reactively-sputtered
- Patterned using shadow masks

TaN Multifunctional Rosette

- Patterned using lift-off
- Gauge Factor: 3.9
- Resistivity: $259 \mu\Omega\text{-cm}$ @ 20°C
- TCR: $-93 \text{ ppm}/^\circ\text{C}$
- $\epsilon_a/\Delta T$: $-24 \mu\epsilon/^\circ\text{C}$ ($>20\mu\epsilon/^\circ\text{C}$)



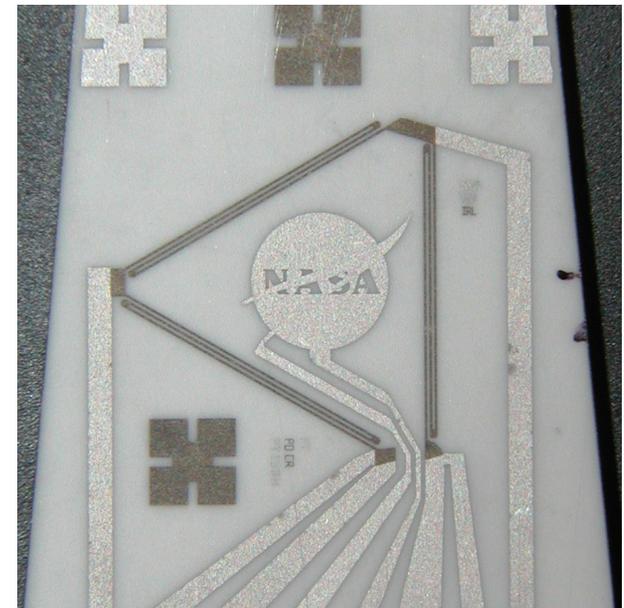
TaN Multifunctional Sensor Strain Output

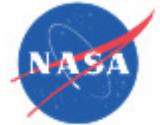




Multilayered Multifunctional Sensor

- TaN layered to PdCr strain gauge for the passive elimination of apparent strain sensitivity
- Initial test to 150°C
 - Gauge Factor: 1.2
 - Resistivity: 146 $\mu\Omega\text{-cm}$
 - TCR: +15 ppm/°C
 - $\epsilon_a/\Delta T$: +12 $\mu\epsilon/\text{°C}$ (<20 $\mu\epsilon/\text{°C}$)
- Follow-up test to 600°C
 - Unstable: $\epsilon_a/\Delta T$: +156 $\mu\epsilon/\text{°C}$ (>20 $\mu\epsilon/\text{°C}$)
- Potential Issues
 - Multilayer Delamination / Diffusion
 - Compatible with sacrificial lift-off patterning process (Reactivity)
 - High Temperature Expansion Issues (CTE)
- Other Materials? (AFRL NDE Branch)



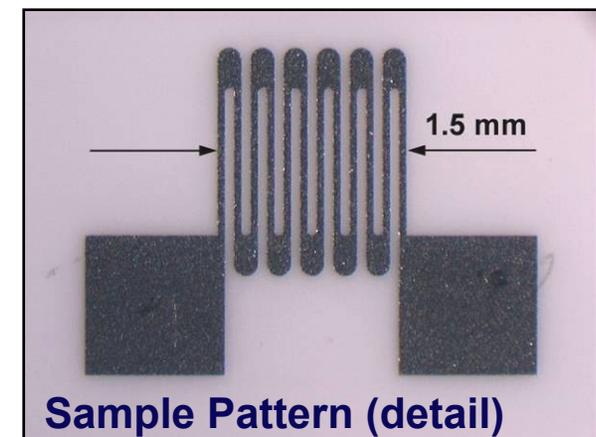


AFRL/NASA SAA3-307-A30



Film	Ar/N/O flow mix	Deposition Time	Thickness	Resistivity	TCR	ΔR_o for 200°C Cycle
Ti	40/0/0	369 min.	2.0 μm	133 $\mu\Omega\text{-cm}$	1360 ppm/°C	4.45%
TiN	38/2/0	1200 min.	2.8 μm	1490 $\mu\Omega\text{-cm}$	624 ppm/°C	114%
TiON	18/1/0.5	360 min.	0.6 μm	62 $\mu\Omega\text{-cm}$	1400 ppm/°C	0.83%
Zr	40/0/0	198 min.	2.0 μm	140 $\mu\Omega\text{-cm}$	1090 ppm/°C	2.73%
ZrN	38/2/0	750 min.	2.4 μm	1090 $\mu\Omega\text{-cm}$	146 ppm/°C	4.26%
ZrON	18/1/0.5	360 min.	1.7 μm	82 $\mu\Omega\text{-cm}$	695 ppm/°C	-1.3%

- All films fabricated using a 3" unbalanced magnetron source at 125W RF
- All films patterned & vacuum annealed at 600°C
- Initial TCR tests to 200°C in air using a 4-wire method
- ON films more stable in air
- Examining Al incorporation, multilayered films



Aircraft Aging & Durability: Novel Thin Film Sensor Technology



Problem:

- Degradation and damage that develops over time in hot section components can lead to catastrophic failure.
- Poor characterization of degradation processes in harsh environment conditions hinders development of durable hot section components

Demonstrated Need:

- Very difficult to model turbine blade temperatures, strains, heat fluxes; measurements are needed
- The turbine section has been consistently responsible for >\$40M/yr in losses to the Air Force

Project Content:

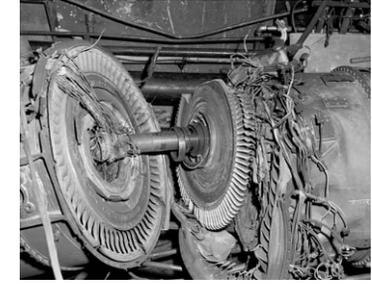
- Develop new sensor and insulation materials capable of withstanding the hot section environment
- Develop techniques for applying sensors onto complex high temperature structures
- Develop thin film sensors to measure temperature, strain, and heat flux during aging studies for hot propulsion materials.

Current SOA:

- Wire thermocouples, strain gauges-disrupt flow, change thermal & mechanical behavior of substrate
- Metal thin films, NiCoCrALY insulation

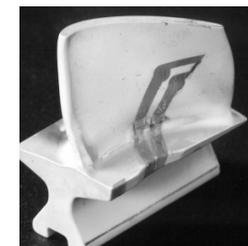
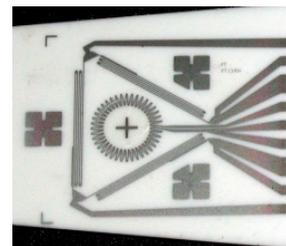


Catastrophic Turbine Engine Failures



Value Added, Contribution of Research:

- New bulk and nano-structured sensor materials with tailored properties
- Novel thin film harsh environment sensors for high temperature characterizations



On-Component Thin Film Sensors for Harsh Environments



Summary of Ceramics of Interest and Application

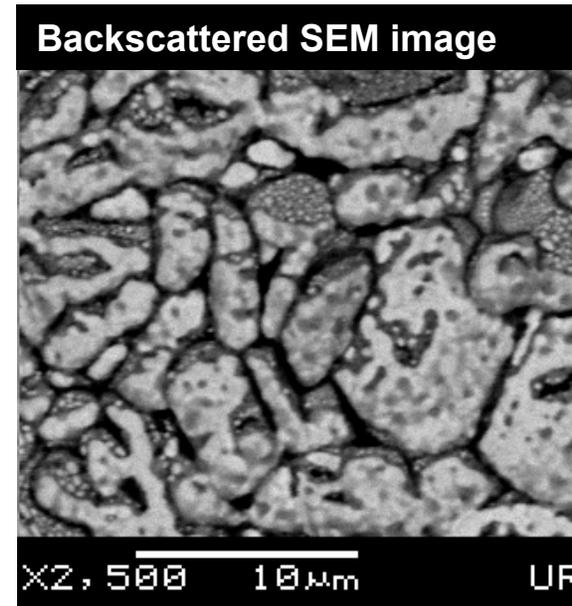
Ceramic	Thermocouple	RTD	Strain Gauge	Flow Sensor
TiC	X			
ZrC	X		X	
TaC	X			
CrSi ₂	X			
MoSi ₂		X		X
TaSi ₂	X			
CrN	X			
ZrN		X	X	X
TaN			X	
CrB ₂		X		X
ZrB ₂			X	
TiB ₂			X	

- Film Fabrication and Testing a challenge; Purity large concern

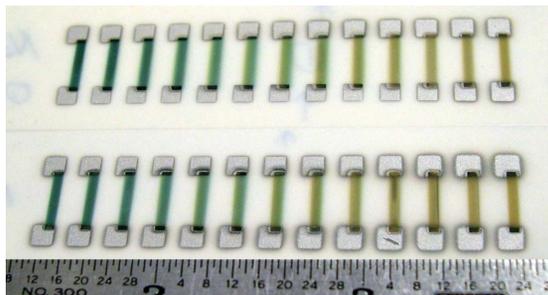


ITO-Nanocomposite Thin Film Strain Gages (NASA Grant NNCO5GA67G w/ U. of Rhode Island)

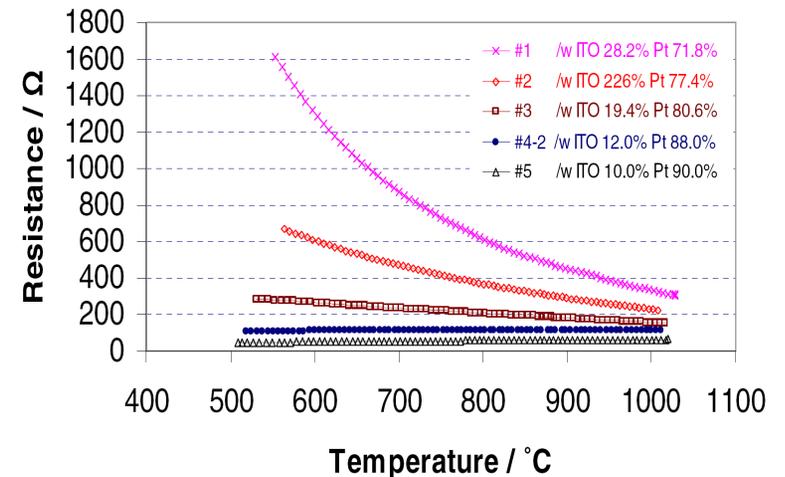
- Low TCR nanocomposite strain gages fabricated by co-sputtering Indium-Tin Oxide (ITO) and refractory metals
- The TCR's measured for several ITO-Pt mixtures via Combinatorial Library
- Candidate Sample Result:
 - Gauge Factor: -26
 - TCR: -50 ppm/°C
 - $\epsilon_a/\Delta T$: +2 $\mu\epsilon/^\circ\text{C}$ (< 20 $\mu\epsilon/^\circ\text{C}$)
- Physics not understood at this time; more studies on-going



Equal Volumes of Pt and ITO
→ Min. TCR



Combinatorial Strain Gauge Library





Summary

- For the advanced engines in the future, knowledge of the physical parameters of the engine and components is necessary on the test stand and in flight
- NASA GRC is leveraging expertise in thin films and high temperature materials for applications of thin film ceramic sensors
- Attempts to improve thermal stability with Tantalum Nitride with an interlayered Palladium-Chromium strain gauge was met with positive results initially, but proved unstable
- Under AFRL/NASA SSA, began examination of other nitrides as possible candidates for ultra-high temperature strain gauges
- Currently examining sputtered films of candidate materials as sensors through NASA's Aircraft Aging & Durability (AAD) Project
- AAD is also sponsoring University of Rhode Island to examine nanostructured films as strain gauge materials



Acknowledgements

- Craig Neslen of the AFRL Nondestructive Evaluation (NDE) Branch at WPAFB for support and discussions related to this work
- Dr. Gary Hunter of the NASA GRC Sensors and Electronics Branch for his participation in discussions and advocacy of this work
- Dr. Otto Gregory of University of Rhode Island Dept. of Chemical Engineering for his studies in thin film ITO sensors
- Staff of the NASA GRC Test Facilities Operation, Maintenance, and Engineering (TFOME) organization in support of the fabrication and test capabilities of the NASA GRC Microsystems Fabrication Clean Room Facility.